Search Notes			

Application/Control No.	Applicant(s)/Patent unde Reexamination	er
10/525,979	SANO ET AL.	
Examiner	Art Unit	
Luctio B. Eischor	1701	

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156	556	12/10/2007	JRF

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PGPub to	ext search	12/10/2007	JRF

SEAR (INCLUDING SI	CH NOTES EARCH STRATEGY)	)
	DATE	EXMR
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